

900V N-Channel MOSFET

General Description

This Power MOSFET is produced using advanced planar stripe DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

Features

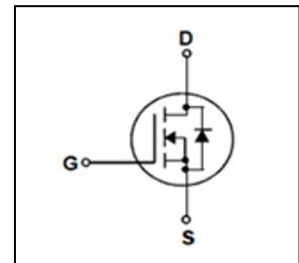
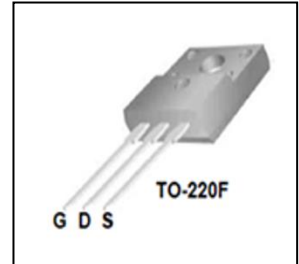
7A, 900V, $R_{DS(on)}$ typ. = 1.65 Ω @VGS = 10 V

Low gate charge (41.5nC)

High ruggedness

Fast switching

Improved dv/dt capability



Absolute Maximum Ratings T_c = 25 °C unless otherwise noted

Symbol	Parameter		JFFM7N90C	Units
V _{DSS}	Drain – Source Voltage		900	V
I _D	Drain Current	Continuous (T _c = 25 °C)	7	A
		Continuous (T _c = 100 °C)	4*	A
I _{DM}	Drain Current - Pulsed (Note 1)		28	A
V _{GSS}	Gate – Source Voltage		±30	V
EAS	Single Pulsed Avalanche Energy (Note 2)		258	mJ
I _{AR}	Avalanche Current (Note 1)		7	A
E _{AR}	Repetitive Avalanche Energy (Note 1)		20	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		5.0	V/ns
P _D	Power Dissipation (T _c = 25 °C)		48	W
	-Derate above 25 °C		0.364	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55~150	°C
T _L	Maximum lead temperature for soldering purposes 1/8" from case for 5 seconds		300	°C

*Drain current limited by maximum junction temperature.

Thermal characteristics

Symbol	Parameter	JFFM7N90C	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	2.6	$^{\circ}\text{C}/\text{W}$
$R_{\theta JS}$	Thermal Resistance, Case-to-Sink Typ.	--	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	$^{\circ}\text{C}/\text{W}$

Electrical Characteristics $T_c = 25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV _{DSS}	Drain – Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 uA	900	--	--	V
ΔBV _{DSS} /ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 uA, Referenced to 25 °C	--	0.65	--	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 900 V, V _{GS} = 0 V	--	--	1	uA
		V _{DS} = 720 V, T _J = 125 °C	--	--	10	uA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{GS} = 0 V	--	--	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{GS} = 0 V	--	--	-100	nA
On Characteristics						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 uA	3.0	--	5.0	V
R _{DS(on)}	Static Drain-Source on-Resistance	V _{GS} = 10 V, I _D = 3.5A	--	1.65	2.15	Ω
g _{FS}	Forward Transconductance	V _{DS} = 20 V, I _D = 3.5 A (Note 4)	--	8.2	--	S
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz	--	1540	--	pF
C _{oss}	Output Capacitance		--	108	--	pF
C _{rss}	Reverse Transfer Capacitance		--	8.19	--	pF
Switching Characteristics						
t _{d(on)}	Turn-On Delay Time	V _{DS} = 520 V, I _D = 7.0 A , R _G = 25Ω , V _{GS} = 10 V (Note 4,5)	--	19	--	ns
t _r	Turn-On Rise Time		--	15	--	ns
t _{d(off)}	Turn-Off Delay Time		--	80	--	ns
t _f	Turn-Off Fall Time		--	22	--	ns
Q _g	Total Gate Charge	V _{DS} = 630 V, I _D = 7.0 A V _{GS} = 10 V (Note 4,5)	--	41.5	--	nC
Q _{gs}	Gate-Source Charge		--	8.15	--	nC
Q _{gd}	Gate-Drain Charge		--	14.95	--	nC
Drain – Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Drain-Source Diode Forward Current		--	--	7	A
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		--	--	28	A
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 7.0 A	--	0.87	1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 7.0 A	--	330	--	ns
Q _{rr}	Reverse Recovery Charge	dI _F /dt = 100 A/us (Note 4)	--	2.5	--	uC

Notes:

1. Repetitive Rating : Pulsed width limited by maximum junction temperature
2. $L = 10\text{ mH}$, $I_{AS} = 7\text{ A}$, $V_{DD} = 50\text{ V}$, $R_G = 25\Omega$, Starting $T_J = 25^{\circ}\text{C}$
3. $I_{SD} \leq 7.0\text{ A}$, $di/dt \leq 200\text{ A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^{\circ}\text{C}$
4. Pulsed Test : Pulsed width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$
5. Essentially independent of operating temperature

Typical Characteristics

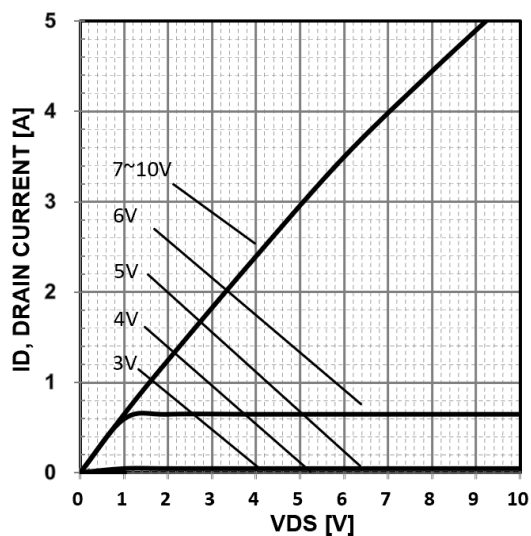


Figure 1. Typical Output Characteristics, $T_c=25^\circ\text{C}$

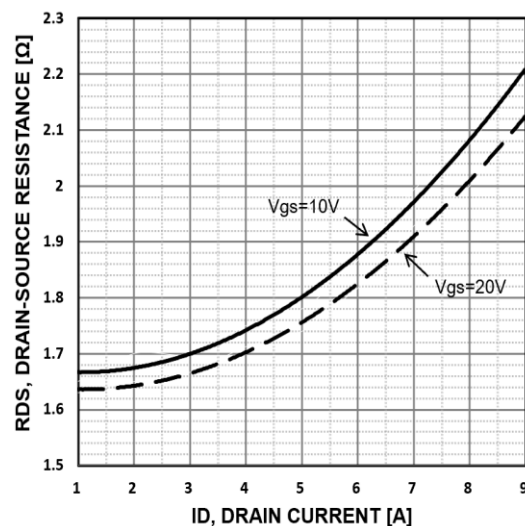


Figure 2. On-Resistance Vs. Drain Current and Gate Voltage

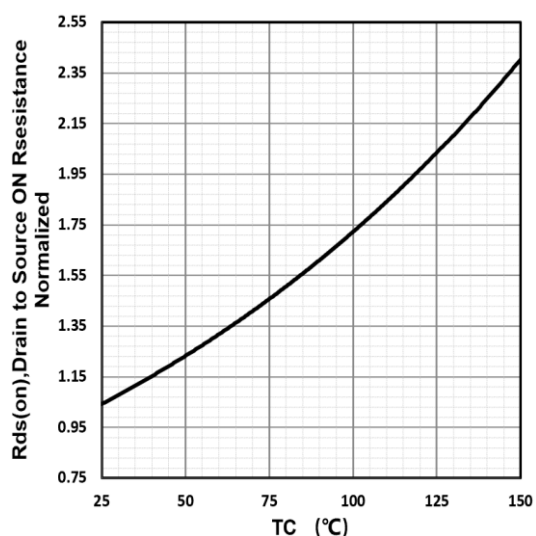


Figure 3. Normalized On-Resistance Vs. Temperature

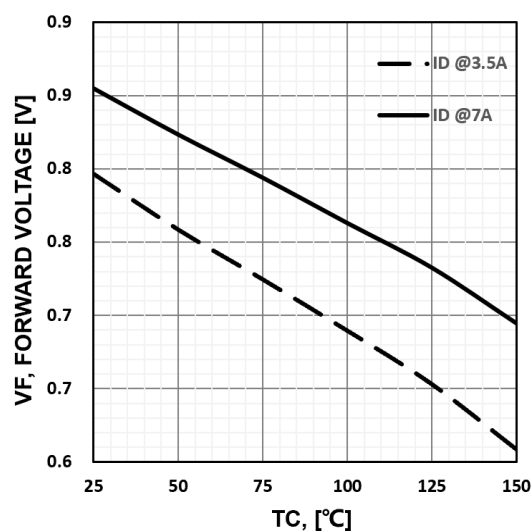


Figure 4. Forward Voltage Vs. Temperature

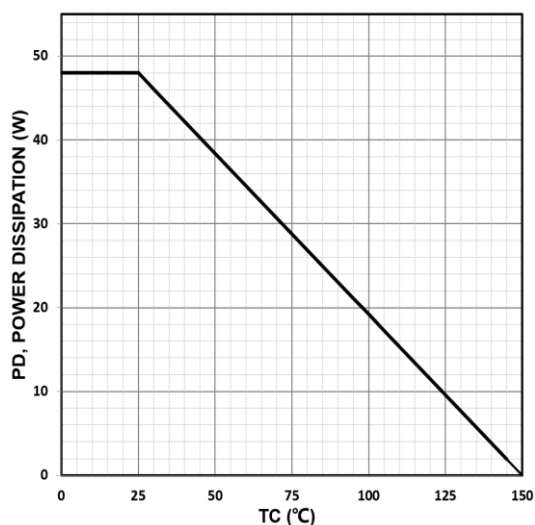


Figure 5. Power Dissipation Vs. Temperature

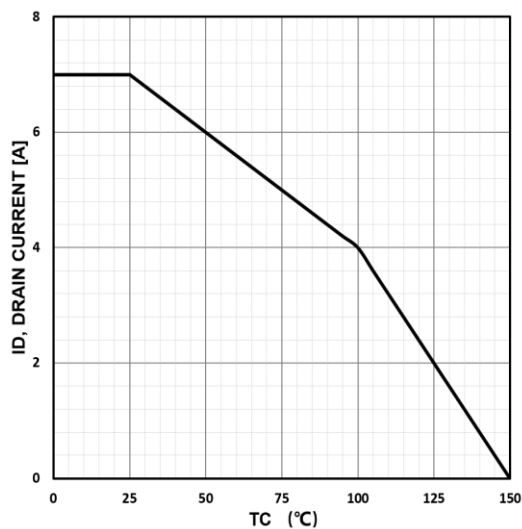


Figure 6. Drain Current Vs. Temperature

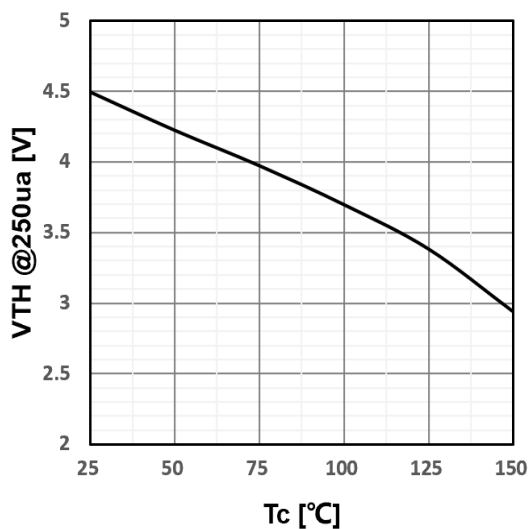


Figure 7. Vth @250ua Vs. Temperature

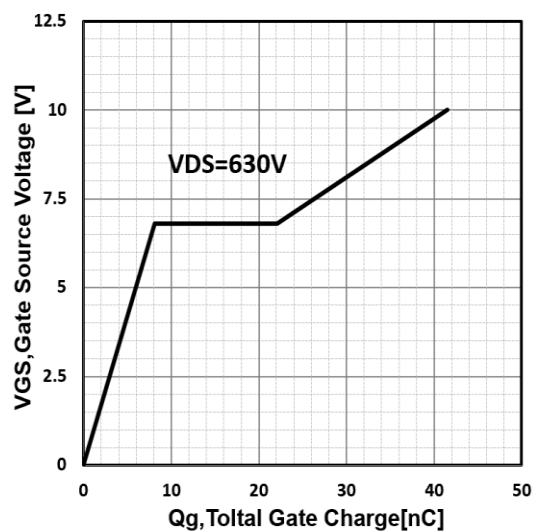


Figure 8. Gate Charge

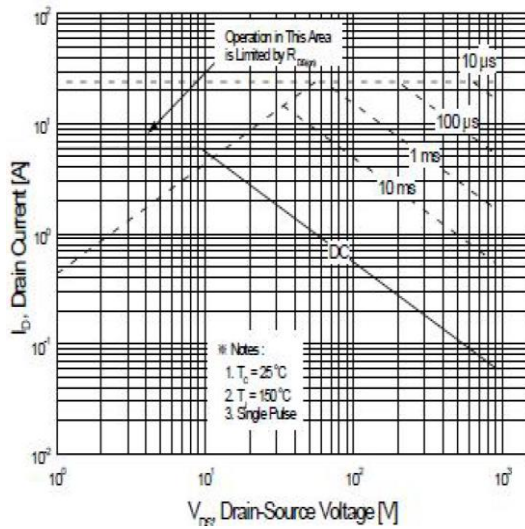
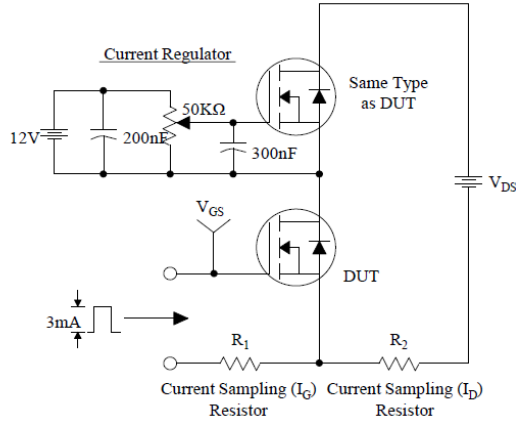
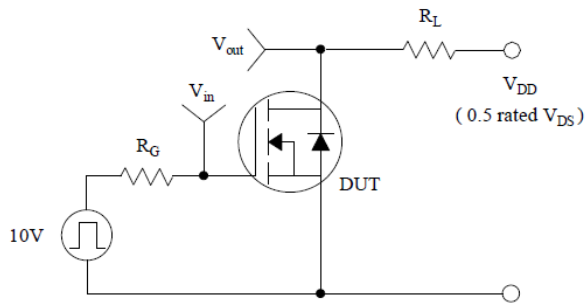
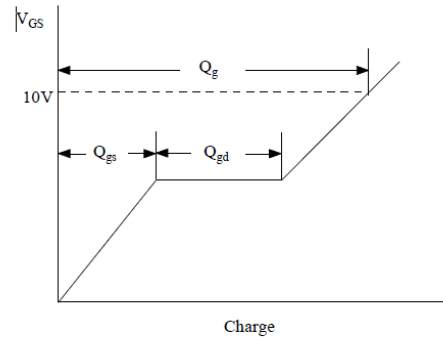


Figure 9. Maximum Safe Operating Area

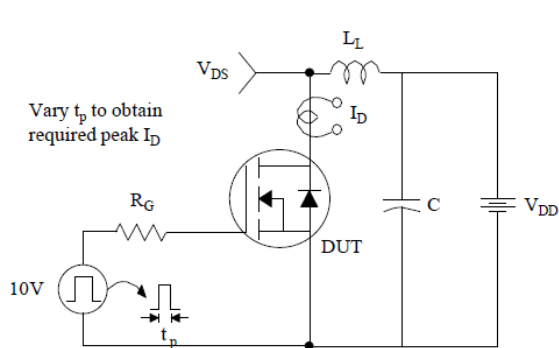
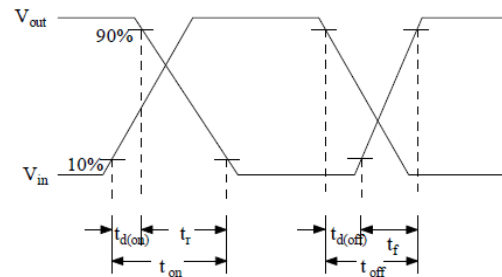
Test Circuit & Waveform



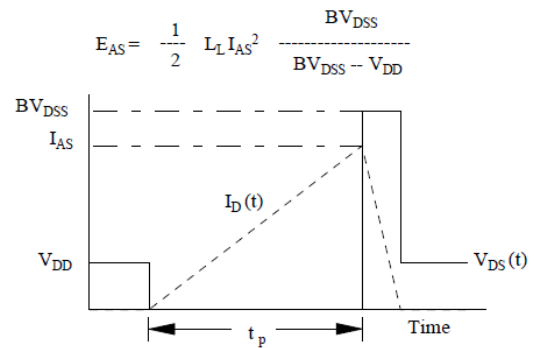
Gate Charge Test Circuit & Waveform



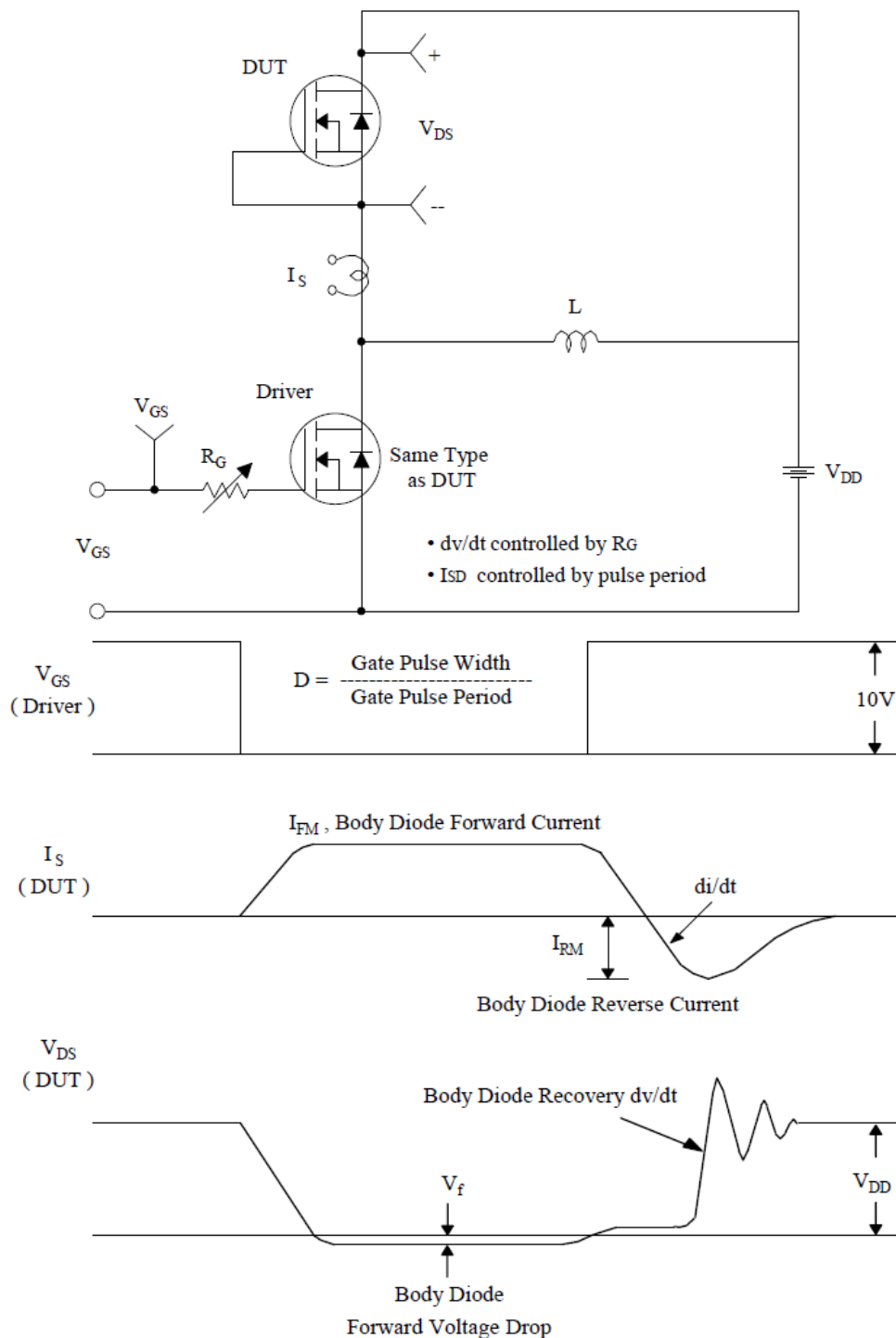
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms

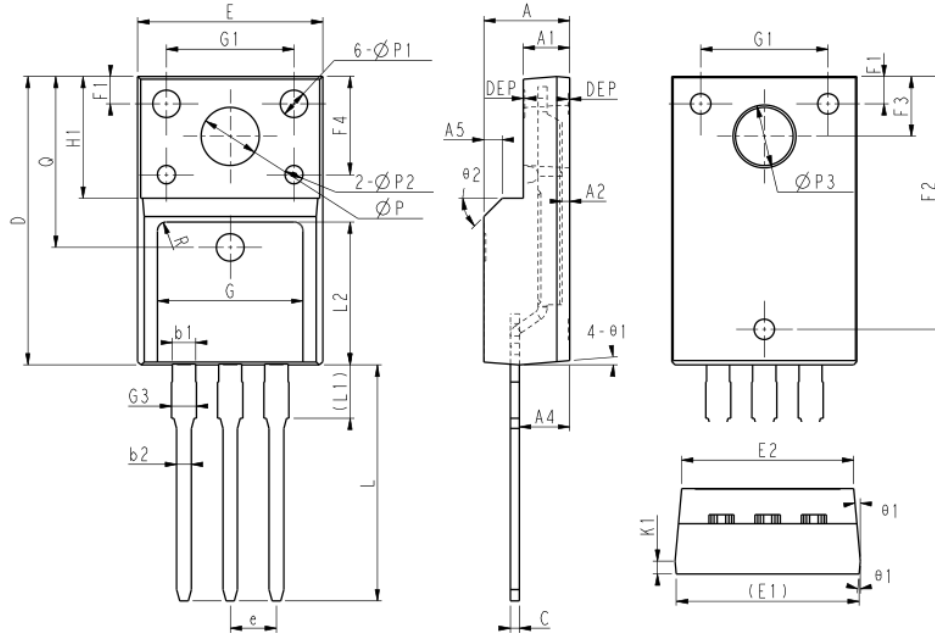


Test Circuit & Waveform



Peak Diode Recovery dv/dt Test Circuit & Waveforms

TO-220F Package



COMMON DIMENSIONS

SYMBOL	MIN	NOM	MAX
E	10.00	10.16	10.32
E1	9.94	10.04	10.14
E2	9.36	9.46	9.56
A	4.50	4.70	4.90
A1	2.34	2.54	2.74
A2	0.43	-	0.48
A4	2.66	2.76	2.86
A5	1.00REF		
c	0.45	0.50	0.60
D	15.67	15.87	16.07
Q	9.40REF		
H1	6.70REF		
e	2.54BSC		
ΦP	3.18REF		
L	12.78	12.98	13.18
L1	2.83	2.93	3.03
L2	7.70	7.80	7.90
ΦP1	1.40	1.50	1.60
ΦP2	0.95	1.00	1.05
ΦP3	3.45REF		
θ1	3°	5°	7°
θ2	-	45°	-
DEP	0.05	0.10	0.15
F1	1.00	1.50	2.00
F2	13.80	13.90	14.00
F3	3.20	3.30	3.40
F4	5.30	5.40	5.50
G	7.80	8.00	8.20
G1	6.90	7.00	7.10
G3	1.25	1.35	1.45
b1	1.23	1.28	1.38
b2	0.75	0.80	0.90
K1	0.65	0.70	0.75
R	0.50REF		

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